

September 20, 2002

FN7156

200MHz Current Feedback Amplifier

élantec.

The EL400 is a wide bandwidth, fast settling monolithic amplifier built using an advanced complementary bipolar

process. This amplifier uses current-mode feedback to achieve more bandwidth at a given gain than conventional operational amplifiers. Designed for closed-loop gains of ±1 to ± 8 , the EL400 has a 200MHz -3dB bandwidth (A_V = ± 2), and 12ns settling to 0.05% while consuming only 15mA of supply current.

The EL400 is an obvious high-performance solution for video distribution and line-driving applications. With low 15mA supply current, differential gain/phase of 0.02%/0.01°, and a minimum 50mA output drive, performance in these areas is assured.

The EL400's settling to 0.05% in 12ns, low distortion, and ability to drive capacitive loads make it an ideal flash A/D driver. The wide 200MHz bandwidth and extremely linear phase allow unmatched signal fidelity. D/A systems can also benefit from the EL400, especially if linearity and drive levels are important.

Ordering Information

| PART NUMBER | TEMP. RANGE | PACKAGE | PKG. NO. |
|----------------|----------------|------------|----------|
| EL400CN | -40°C to +85°C | 8-Pin PDIP | MDP0031 |
| EL400CS | -40°C to +85°C | 8-Pin SO | MDP0027 |

Features

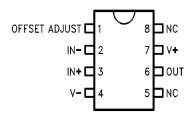
- 200MHz -3dB bandwidth, A_V = 2
- 12ns settling to 0.05%
- V_S = ±5V @ 15mA
- Low distortion: HD2, HD3 @ -60dBc at 20MHz
- · Differential gain 0.02% at NTSC, PAL
- Differential phase 0.01° at NTSC, PAL
- · Overload/short-circuit protected
- ±1 to ±8 closed-loop gain range
- Low cost
- Direct replacement for CLC400

Applications

- · Video gain block
- Video distribution
- HDTV amplifier
- · High-speed A/D conversion
- D/A I-V conversion
- · Photodiode, CCD preamps
- IF processors
- · High-speed communications

Pinout

EL400 (8-PIN PDIP, SO) TOP VIEW



Manufactured under U.S. Patent No. 4,893,091

Absolute Maximum Ratings (T_A = 25°C)

| Supply Voltage (V _S)±7V | Operating Temperature |
|---|---|
| Output Current | Pin Temperature (Soldering, 5 Seconds)300°C |
| Output is short-circuit protected to ground, however, maximum | Junction Temperature175°C |
| reliability is obtained if I _{OUT} does not exceed 70mA. | Storage Temperature60°C to +150°C |
| Common-Mode Input Voltage ±V _S | Thermal Resistance: θ _{JA} = 95°C/W PDIP |
| Differential Input Voltage5V | θ _{JA} = 175°C/W SO-8 |
| Power Dissipation See Curves | |

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

IMPORTANT NOTE: All parameters having Min/Max specifications are guaranteed. Typical values are for information purposes only. Unless otherwise noted, all tests are at the specified temperature and are pulsed tests, therefore: $T_J = T_C = T_A$

Open-Loop DC Electrical Specifications $V_S = \pm 5V$, $R_L = 100\Omega$ unless otherwise specified.

| PARAMETER | DESCRIPTION | TEST CONDITIONS | TEMP | MIN | TYP | MAX | UNIT |
|-------------------------------------|------------------------------|-----------------|------------------------|-------|-------|-------|-------|
| V _{OS} | Input Offset Voltage | | 25°C | | 2.0 | 5.5 | mV |
| | | | T _{MIN} | | | 8.7 | mV |
| | | | T _{MAX} | | | 9.5 | mV |
| d(V _{OS})/d _T | Average Offset Voltage Drift | (Note 1) | All | | 10.0 | 40.0 | μV/°C |
| +I _{IN} | +Input Current | | 25°C, T _{MAX} | | 10.0 | 25.0 | μA |
| | | | T _{MIN} | | | 41.0 | μA |
| d(+I _{IN})/d _T | Average +Input Current Drift | (Note 1) | All | | 50.0 | 200.0 | nA/°C |
| -l _{IN} | -Input Current | | 25°C | | 10.0 | 25.0 | μΑ |
| | | | T _{MIN} | | | 41.0 | μΑ |
| | | | T _{MAX} | | | 35.0 | μΑ |
| d(-I _{IN})/dT | Average -Input Current Drift | (Note 1) | All | | 100.0 | 200.0 | nA/°C |
| PSRR | Power Supply Rejection Ratio | | All | 40.0 | 50.0 | | dB |
| CMRR | Common-Mode Rejection Ratio | | All | 40.0 | 50.0 | | dB |
| Is | Supply Current—Quiescent | No Load | All | | 15.0 | 23.0 | mA |
| +R _{IN} | +Input Resistance | | 25°C, T _{MAX} | 100.0 | 200.0 | | kΩ |
| | | | T _{MIN} | 50.0 | | | kΩ |
| C _{IN} | Input Capacitance | | All | | 0.5 | 2.0 | pF |
| R _{OUT} | Output Impedance (DC) | | All | | 0.1 | 0.2 | W |
| CMIR | Common-Mode Input Range | (Note 2) | 25°C, T _{MAX} | 2.0 | 2.1 | | V |
| | | | T _{MIN} | 1.2 | | | V |
| lout | Output Current | | 25°C, T _{MAX} | 50.0 | 70.0 | | mA |
| | | | T _{MIN} | 35.0 | | | mA |
| V _{OUT} | Output Voltage Swing | No Load | All | 3.2 | 3.5 | | V |
| V _{OUTL} | Output Voltage Swing | 100Ω | 25°C | 3.0 | 3.4 | | V |
| R _{OL} | Transimpedance | | 25°C | 30.0 | 125.0 | | V/mA |
| | | | T _{MIN} | | 80.0 | | V/mA |
| | | | T _{MAX} | | 140.0 | | V/mA |

NOTES:

- 1. Measured from $T_{\mbox{\footnotesize{MIN}}}$ to $T_{\mbox{\footnotesize{MAX}}}.$
- 2. Common-Mode Input Range for Rated Performance.

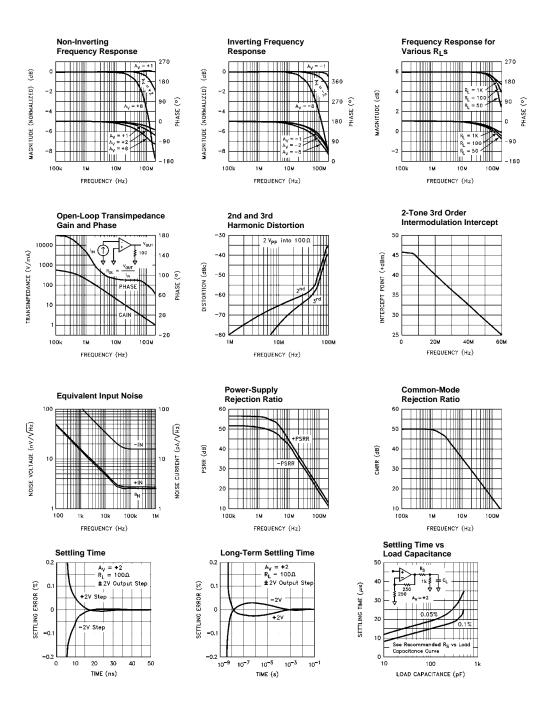
Closed-Loop AC Electrical Specifications

| PARAMETE | R | DESCRIPTION | TEST CONDITIONS | TEMP | MIN | TYP | MAX | UNITS |
|-------------------|-----------------------------------|---|----------------------|-------------------------------------|-------|--------|--------|-----------------|
| Frequency | SSBW | -3dB Bandwidth | | 25°C | 150.0 | 200.0 | | MHz |
| Response | | $(V_{OUT} < 0.5V_{PP})$ | | T _{MIN} | 150.0 | | | MHz |
| | | | | T _{MAX} | 120.0 | | | MHz |
| | LSBW | -3dB Bandwidth (V _{OUT} < 5.0V _{PP}) | A _V = +5 | All | 35.0 | 50.0 | | MHz |
| Gain Flatness | GFPL | Peaking V _{OUT} < 0.5V _{PP} | < 40MHz | 25°C | | 0.0 | 0.3 | dB |
| | | | | T _{MIN} , T _{MAX} | | | 0.4 | dB |
| | GFPH | Peaking V _{OUT} < 0.5V _{PP} | > 40MHz | 25°C | | 0.0 | 0.5 | dB |
| | | | | T _{MIN} , T _{MAX} | | | 0.7 | dB |
| | GFR | Rolloff | < 75MHz | 25°C | | 0.6 | 1.0 | dB |
| | | $V_{OUT} < 0.5V_{PP}$ | | T _{MIN} | | | 1.0 | dB |
| | | | | T _{MAX} | | | 1.3 | dB |
| | LPD | Linear Phase Deviation V _{OUT} < 0.5V _{PP} | < 75MHz | 25°C, T _{MIN} | | 0.2 | 1.0 | 0 |
| | | | | T _{MAX} | | | 1.2 | 0 |
| Time-Domain | t _{R1} , t _{F1} | Rise Time, Fall Time | 0.5V Step | 25°C, T _{MIN} | | 1.6 | 2.4 | ns |
| Response | | | | T _{MAX} | | | 2.9 | ns |
| | t _{R2} , t _{F2} | Rise Time, Fall Time | 5.0V Step | All | | 6.5 | 10.0 | ns |
| | t _{S1} | Settling Time to 0.1% | 2.0V Step | All | | 10.0 | 13.0 | ns |
| | t _{S2} | Settling Time to 0.05% | 2.0V Step | All | | 12.0 | 15.0 | ns |
| | os | Overshoot | 0.5V Step | 25°C | | 0.0 | 10.0 | % |
| | | | | T _{MIN} , T _{MAX} | | | 15.0 | % |
| | SR | Slew Rate | A _V = +2 | All | 430.0 | 700.0 | | V/µs |
| | | | A _V = - 2 | All | | 1600.0 | | V/µs |
| Distortion | HD2 | 2nd Harmonic Distortion at 20MHz | 2V _{PP} | 25°C | | -60.0 | -45.0 | dBc |
| | | | | T _{MIN} | | | -40.0 | dBc |
| | | | | T _{MAX} | | | -45.0 | dBc |
| | HD3 | 3rd Harmonic Distortion at | 2V _{PP} | 25°C | | -60.0 | -50.0 | dBc |
| | | 20MHz | | T _{MIN} , T _{MAX} | | | -50.0 | dBc |
| Equivalent Input | NF | Noise Floor > 100kHz | (Note 1) | 25°C | | -157.0 | -154.0 | dBm (1Hz) |
| Noise | | | | T _{MIN} | | | -154.0 | dBm (1Hz) |
| | | | | T _{MAX} | | | -153.0 | dBm (1Hz) |
| | INV | Integrated Noise 100kHz to 200MHz | (Note 1) | 25°C | | 40.0 | 57.0 | μV |
| | | | | T _{MIN} | | | 57.0 | μV |
| | | | | T _{MAX} | | | 63.0 | μV |
| Video Performance | d _G | Differential Gain (Note 2) | NTSC/PAL | 25°C | | 0.02 | | % _{PP} |
| | d _P | Differential Phase (Note 2) | NTSC/PAL | 25°C | | 0.01 | | °PP |
| | d _G | Differential Gain (Note 2) | 30MHz | 25°C | | 0.05 | | % _{PP} |
| | d _P | Differential Phase (Note 2) | 30MHz | 25°C | | 0.05 | | °PP |
| | VBW | -0.1dB Bandwidth (Note 2) | | 25°C | | 60.0 | | MHz |

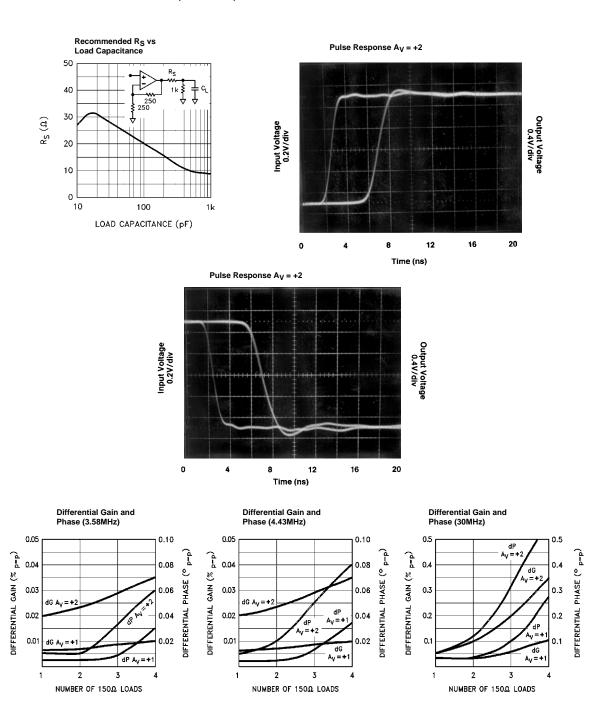
NOTES:

- 1. Noise Tests are Performed from 5MHz to 200MHz.
- 2. Differential Gain/Phase Tests are R_L = $100\Omega.$ For other values of $R_L,$ see curves.

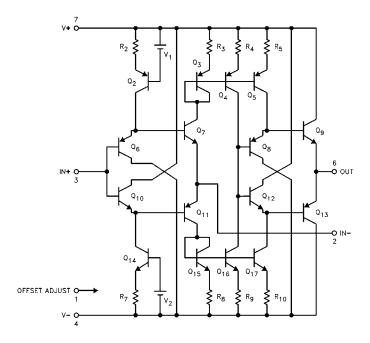
Typical Performance Curves



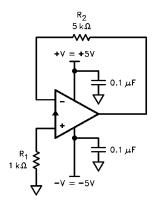
Typical Performance Curves (Continued)



Equivalent Circuit



Burn-In Circuit



All Packages Use The Same Schematic.

Applications Information

Theory of Operation

The EL400 has a unity gain buffer from the non-inverting input to the inverting input. The error signal of the EL400 is a current flowing into (or out of) the inverting input. A very small change in current flowing through the inverting input will cause a large change in the output voltage. This current amplification is called the transimpedance (R_{OL}) of the EL400 [V_{OUT} = (R_{OL})*(-I_{IN})]. Since R_{OL} is very large, the

current flowing into the inverting input in the steady-state (non-slewing) condition is very small.

Therefore we can still use op-amp assumptions as a firstorder approximation for circuit analysis, namely that:

- 1. The voltage across the inputs is approximately 0V.
- 2. The current into the inputs is approximately 0mA.

Resistor Value Selection and Optimization

The value of the feedback resistor (and an internal capacitor) sets the AC dynamics of the EL400. The nominal value for

the feedback resistor is 250Ω , which is the value used for production testing. This value guarantees stability. For a given closed-loop gain the bandwidth may be increased by decreasing the feedback resistor and, conversely, the bandwidth may be decreased by increasing the feedback resistor.

Reducing the feedback resistor too much will result in overshoot and ringing, and eventually oscillations. Increasing the feedback resistor results in a lower -3dB frequency. Attenuation at high frequency is limited by a zero in the closed-loop transfer function which results from stray capacitance between the inverting input and ground. Consequently, it is very important to keep stray capacitance to a minimum at the inverting input.

Differential Gain/Phase

An industry-standard method of measuring the distortion of a video component is to measure the amount of differential gain and phase error it introduces. To measure these, a 40 IRE_{PP} reference signal is applied to the device with 0V DC offset (0IRE) at 3.58MHz for NTSC, 4.43MHz for PAL, and 30MHz for HDTV. A second measurement is then made with a 0.714V DC offset (100IRE). Differential Gain is a measure of the change in amplitude of the sine wave, and is measured in percent. Differential Phase is a measure of the change in phase, and is measured in degrees. Typically, the maximum positive and negative deviations are summed to give peak values.

In general, a back terminated cable (75Ω in series at the drive end and 75Ω to ground at the receiving end) is preferred since the impedance match at both ends will absorb any reflections. However, when double-termination is used, the received signal is reduced by half; therefore a gain of 2 configuration is typically used to compensate for the attenuation. In a gain of 2 configuration, with output swing of $2V_{PP}$ with each back-terminated load at 150Ω . The EL400 is capable of driving up to 4 back-terminated loads with excellent video performance. Please refer to the typical curves for more information on video performance with respect to frequency, gain, and loading.

Capacitive Feedback

The EL400 relies on its feedback resistor for proper compensation. A reduction of the impedance of the feedback element results in less stability, eventually resulting in oscillation. Therefore, circuit implementations which have capacitive feedback should not be used because of the capacitor's impedance reduction with frequency. Similarly, oscillations can occur when using the technique of placing a capacitor in parallel with the feedback resistor to compensate for shunt capacitances from the inverting input to ground.

Offset Adjustment Pin

Output offset voltage of the EL400 can be nulled by tying a 10k potentiometer between $+V_S$ and $-V_S$ with the slider attached to pin 1. A full-range variation of the voltage at pin 1 to $\pm 5V$ results in an offset voltage adjustment of at least ± 10 mV. For best settling performance pin 1 should be bypassed to ground with a ceramic capacitor located near to the package, even if the offset voltage adjustment feature is not being used.

Printed Circuit Layout

As with any high frequency device, good PCB layout is necessary for optimum performance. Ground plane construction is a requirement, as is good power-supply and Offset Adjust bypassing close to the package. The inverting input is sensitive to stray capacitance, therefore connections at the inverting input should be minimal, close to the package, and constructed with as little coupling the ground plane as possible.

Capacitance at the output node will reduce stability, eventually resulting in peaking, and finally oscillation if the capacitance is large enough. The design of the EL400 allows a larger capacitive load than comparable products, yet there are occasions when a series resistor before the capacitance may be needed. Please refer to the graphs to determine the proper resistor value needed.

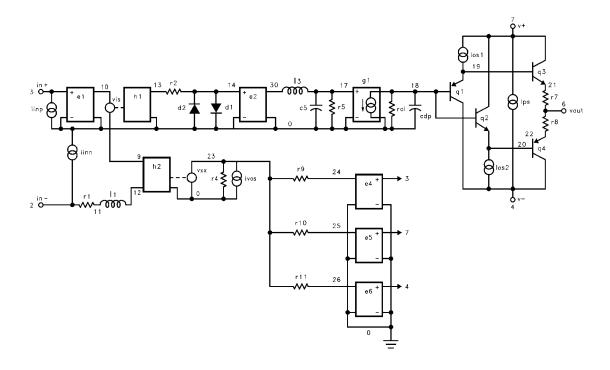
EL400 Macromodel

```
* Revision A. March 1992
* Enhancements include PSRR, CMRR, and Slew Rate Limiting
* Connections: +input
              -input
                 +Vsupply
                    -Vsupply
                        output
                    2
                        7
                            4
.subckt M400
                3
                                6
* Input Stage
e1 10 0 3 0 1.0
vis 10 9 0V
h2 9 12 vxx 1.0
r1 2 11 50
I1 11 12 48nH
iinp 3 0 8µA
iinm 2 0 8µA
* Slew Rate Limiting
h1 13 0 vis 600
r2 13 14 1K
d1 14 0 dclamp
d2 0 14 dclamp
* High Frequency Pole
*e2 30 0 14 0 0.00166666666
I3 30 17 0.1μH
c5 17 0 0.1pF
r5 17 0 500
* Transimpedance Stage
g1 0 18 17 0 1.0
rol 18 0 150K
cdp 18 0 2.8pF
* Output Stage
q1 4 18 19 qp
q2 7 18 20 qn
q3 7 19 21 qn
q4 4 20 22 qp
r7 21 6 2
r8 22 6 2
ios1 7 19 2.5mA
ios2 20 4 2.5mA
* Supply Current
ips 7 4 9mA
* Error Terms
ivos 0 23 5mA
```

EL400 Macromodel (Continued)

```
vxx 23 0 0V
e4 24 0 3 0 1.0
e5 25 0 7 0 1.0
e6 26 0 4 0 1.0
r9 24 23 3K
r10 25 23 1K
r11 26 23 1K
*

* Models
*
.model qn npn (is=5e-15 bf=200 tf=0.5nS)
.model qp pnp (is=5e-15 bf=200 tf=0.5nS)
.model dclamp d(is=1e-30 ibv=0.266 bv=1.3 n=4)
.ends
```



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